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CCS A 61

JJG

**INDUSTRY STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

JJG 629-2014

Replacing JJG 629-1989

**Verification Regulation for Polycrystalline X-ray Diffractometers
(English Translation)**

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What this standard covers

This Standard specifies the multi-crystal X-ray diffraction (hereinafter referred to as the instrument) the initial verification, verification and subsequent use of checks.

Document data

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Standards quoted by this document

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